

unit IV

FIBER OPTIC RECEIVER & MEASUREMENTS

This chapter covers

- ⇒ Fundamental Rx operation
- † Pre amplifiers
- † Back sources
- ⇒ Rx config
- † Probability of Errors
- † Quantum limit

①

Fundamentals of operation

- + The design of optical Rx is much more complicated than that of an optical Tx.
- + Since the Rx must first detect weak signal, distorted signals & then make decisions on what type of data was sent based on an amplified version of the distorted signal.
- + When the optical data are incident on the APD, higher current pulses flow through the circuit.

- + The photo current is amplified by the preamplifier.



It converts the voltage pulses to have adequate voltage level.

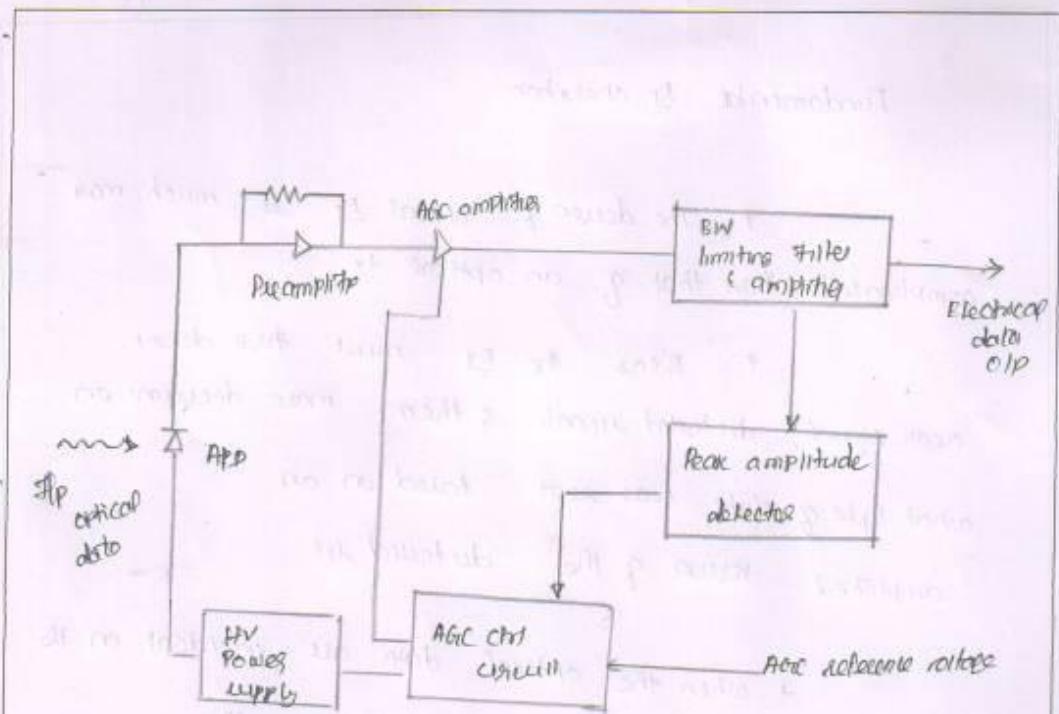


Fig: Fiber optic line Rx

- ⇒ the peak amplitude of the voltage pulses are maintained constant by the AGC controlled amplifier
- ⇒ the signal from the o/p of AGC amplifier is fed back to the AGC amplifier via a peak amplitude detector

⇒ A compensation is made b/w the I/p & reference voltage level
of reg. opt. sol is generated which chg the gain of the

AFIC AMPLIFER

⇒

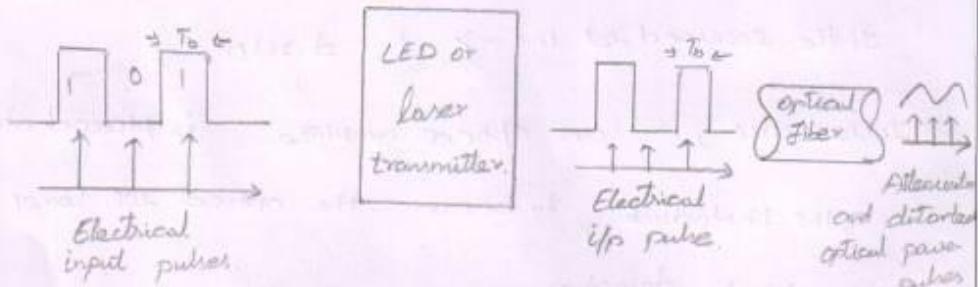


Fig: OPTICAL Tx

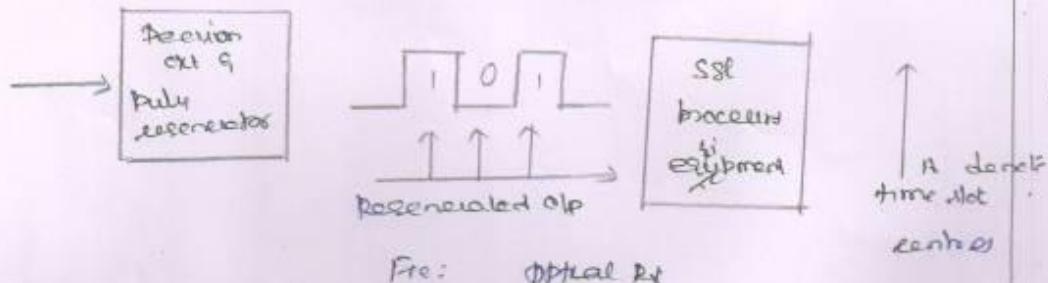
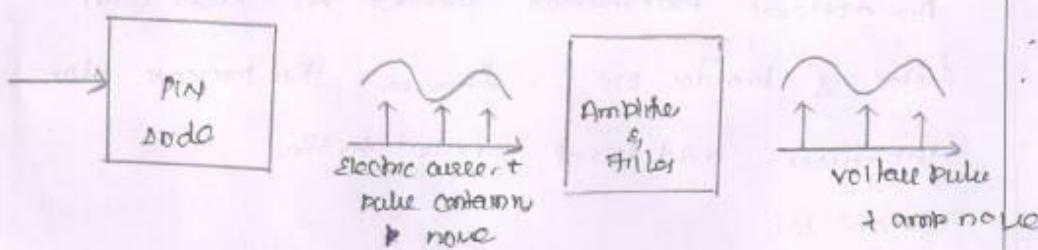


Fig: OPTICAL Rx

threshold level:

It compares the sel in each time slot w/ a certain reference voltage known as threshold level.

$$\text{if } R_{\text{det}} \text{ sel} > \text{threshold} = 1$$

$$\text{if } R_{\text{det}} \text{ sel} < \text{threshold} = 0$$

if the measured sel is $> 1 \pm \text{zero}$

In some case, an optical amplifier is placed ahead of the photodiode to boost the optical sel level before photo detection.

An optical preamplifier provides a large gain factor & broader BW. However, this process also introduces additional noise to the optical ROI.

Bit Period:

- ⇒ The transmitted signal is a 2-level binary data stream consisting of either 0 or 1 in a time slot of duration T_b . This time slot is referred to as bit period.

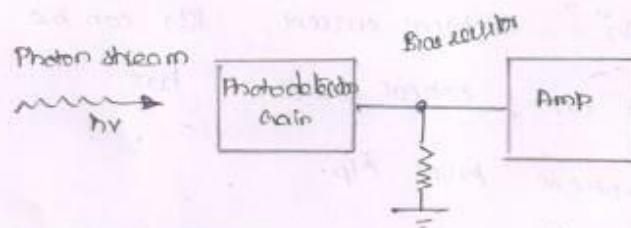
bit Period:

- ⇒ one of the simplest techniques for sending binary data is amplitude shift keying, where a voltage level is switched b/w two values, which are usually on or off.
- ⇒ The optical fiber converts the electrical signal into optical sig. An electrical current $i(t)$ can be used to modulate an optical source to produce an optical power $P(t)$.
- ⇒ Optical sig equivalent for 1 is pulse of optical power of duration T_b where '0' is absence of light. The optical pulse gets attenuated as it propagates in the fiber.

e.g. PIN or avalanche photodiode at the Rx, convert
 the optical signal to electrical sig. Amplified & filtered
 sig are compared in a decision cir w/ the
 threshold voltage.

Error sources

It can arise from various noise &
 disturbance associated w/ signal detection system.



e.g. Photon detection quantum noise
 • Thermal noise

* Bulk leakage current

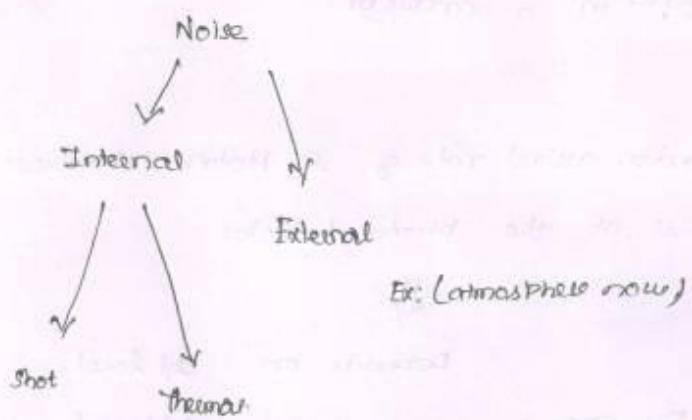
* Surface leakage current

* Gain

Noise: It is a random variation of electric power level.

⇒ Noise source can be either external or internal

to the system.



Internal noise:

⇒ It is caused by the spontaneous fluctuation of current or voltage in electric circuits.

⇒ Two types

they are

⇒ shot noise

⇒ thermal noise

shot noise arises in electronic devices due to the

discrete nature of current flow into device

Thermal noise arises from the random motion of
e.m.f. in a conductor.

- Random arrival rate of all photons produce a quantum noise at the photo detector.

(~~random arrival rate~~) ↑

Depends on light level.

- For APD & photodiode additional shot noise arises from the statistical nature of the multiplication process.

Increasing avalanche gain (λ) ↑

the noise level also ↑

- Breakdown of surface leakage current now becomes independent of the photons. Thermal noise arises owing to the detector load resistor & from the amplifier noise.

- i) The primary photocurrent generated by the
 photodiode is a time varying current because
 resulting from the random arrival of photons at the
 detector.
- ii) If the detector is illuminated by off-axis Rel PE
 then the no. of (σ^2 -bias) photoe \bar{N} is generated
 in a time t is

$$\bar{N} = \frac{q}{hv} \int_0^t p(t) dt$$

$$= \frac{\eta E}{hv}$$

η = detector quantum η

hv = photon energy

E = Energy lost in a time interval t .

The actual no. of photo-pairs is that one generated fluctuates from the average according to the poisson distribution

$$P(n) = \bar{N}_n \frac{\bar{e}^{-\bar{N}_n}}{n!}$$

Point = prob. of n^{th} pair are emitted in an interval t

The random nature of the avalanche multiplication process gives rise to a type of shot noise.

A detector w/ mean avalanche gain M and an ionization rate σ_{ion} , the excess noise factor $F(n)$ for an injection is

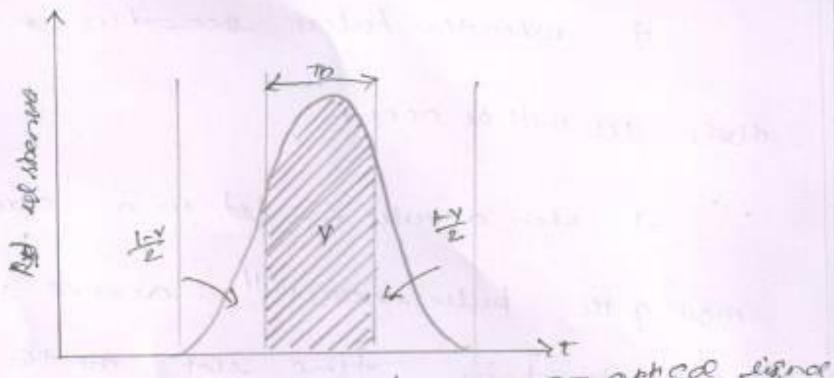
$$F(n) = KM + (2 - 1/M) (1-e^{-\sigma_{ion} t})$$

ISI (Inter symbol Interference)

+ when the pulse spreading is the other fiber, ISI will be occur.

o) when a pulse is fed in a given time slot, most of the pulse energy will receive in the corresponding time slot at the receiver. However, b'coz of pulse spreading induced by the receiver, some of the fed energy will necessarily spread into neighboring time slots on the pulse duration along with the fiber. The presence of this energy in an adjacent time slot results in an interfering signal.

It is called as "Inter symbol Interference" or "ISI".



that leads to π^2

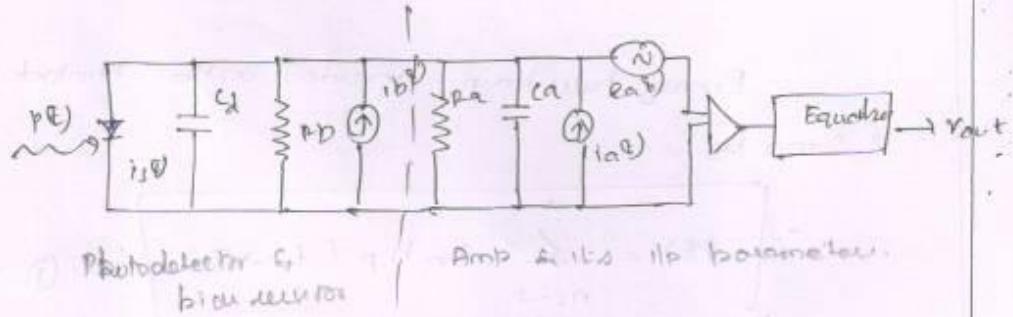
Receiver configuration:

The three basic stages of the Rx are

- # Photo detector
- # An amplifier
- # An evaluator

The PD can be either an avalanche photo diode
w/ gain $M=1$ or PIN PD w/ low gain

PD has a quantum η & Cd (Capacitor).



Photodetector &
bias resistor

Amp as its IP parameter.

Amplifying function is represented by the voltage controlled current source which is characterized by a bias conductance g_m .

Two additional noise sources are there

ii)

Thermal noise due to resistor R_a

Noise voltage source v_n (dB)

These noise sources are assumed to be Gaussian in statistics & have flat spectrum & hence known as white noise.

Expression for mean o/p from PD:

Binary pulse train incident on the Photodiode

is given by

$$P(E) = \sum_{n=-\infty}^{\infty} b_n h_p(t - nT_b) \quad (1)$$

P(E) = Rx optical power

b_n = Amplitude of n^{th} message digit

T_b = bit Period

$h_p(t)$ = Rx Pulse shape

$$\int_{-\infty}^{\infty} h_p(t) dt = 1 \quad (2)$$

Non negative PD input pulse normalized

To have unit area

The mean o/p current from the PD at time 't' due to pulse train is given by

$$\langle I(t) \rangle = \frac{nq}{h_i} NAP(E) \quad (3)$$

sub ① in ③, we get

$$i(t) = R_0 M \sum_{n=0}^{\infty} b_n h_p(t, n\tau_b)$$

$$(\because R_0 = n\eta/h\nu)$$

where η = quantum η .

R_0 = Responsivity of the detector.

quantum limit

For an ideal PD, which has uniform quantum η & which produces no dark current (no electron hole generated).

So, in this condition, it is desirable to find the minimum error rate required to a specific bit error rate performance in a digital system.

quantum limit

$$\boxed{P_r(i) = e^{-N}}$$



Therefore we can find quantum limit